

Ca(Zr,Ti)O₃ Ceramics for Energy Storage Applications

**EMA 2012
Orlando, FL, Jan 19, 2012**

**S. Dai, B.A. Hernandez-Sanchez, T. Garino, P. Lu,
N. S. Bell, J. Wheeler, D.L. Moore and B. A. Tuttle***

**Sandia National Laboratories
*Sandia Staffing Alliance LLC
Albuquerque, New Mexico**

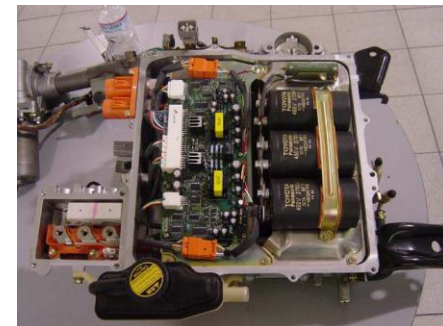
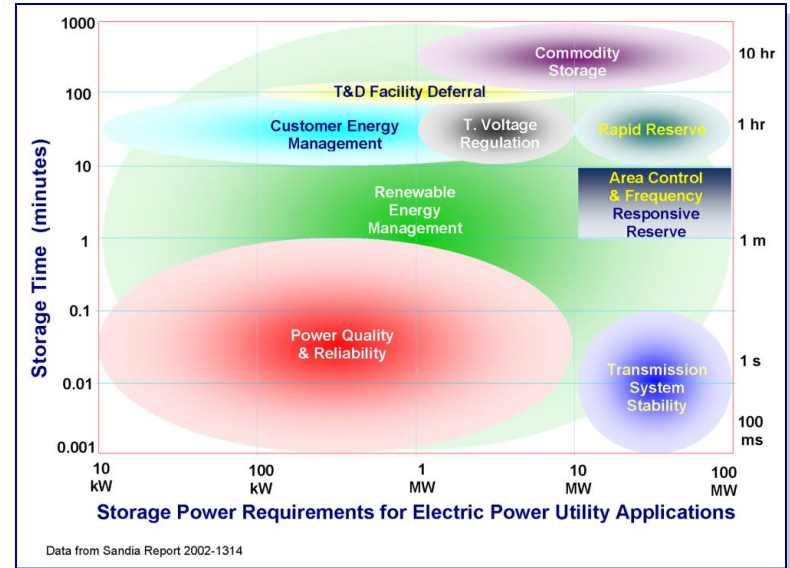


Outline

- Introduction
- Chemical powder synthesis route
 - $\text{Ca}(\text{Zr}_{0.9}\text{Ti}_{0.1})\text{O}_3 \rightarrow \text{CZT90/10}$
- Fabrication of multilayer CZT
 - Powder calcination and 2-step sintering
 - Free standing single and multilayer CZT90/10
- Characterization
 - Microstructure
 - Dielectric properties
 - Energy density
- Summary

Application Requirement

- **Next-Generation Capacitor Requirements:**
 - Reduced volume and temperature insensitive dielectric property
- **Potential Applications:**
 - Power Grid
 - Electric Hybrid and Fuel Cell Vehicles
 - High Frequency Applications
- **Impact:**
 - Increased system reliability
 - Smaller component packages



Toyota Prius Inverter

The large capacitors ~ 35 Vol% of the inverter, the largest and most unreliable parts in the inverter



Trade-offs of Dielectric Materials

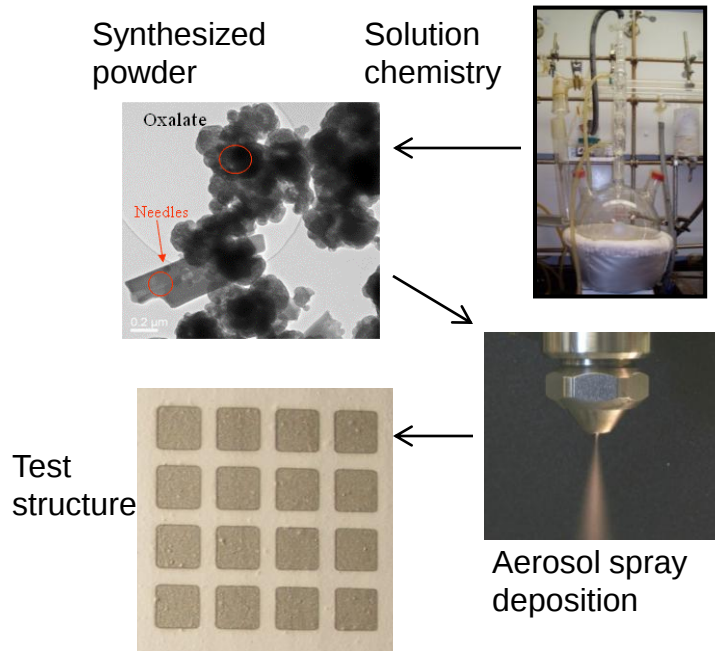
Properties	Low K, high E_{bd} , low TCC	Medium K, high E_{bd} , moderate TCC	High K, medium E_{bd} , high TCC
ϵ	30	80	1200
Tcc (ppm/°C)	120	1000	> 2000
$\Delta\epsilon$ over 200 °C	2.4%	20%	30 – 50%
Example	$\text{CaZrO}_3 - \text{CaTiO}_3$	TiO_2	PLZT

Focus of this presentation

ϵ : dielectric constant
 E_{bd} : dielectric break down field
 T_{cc} : temperature coef of capacitance

Material and Process Review

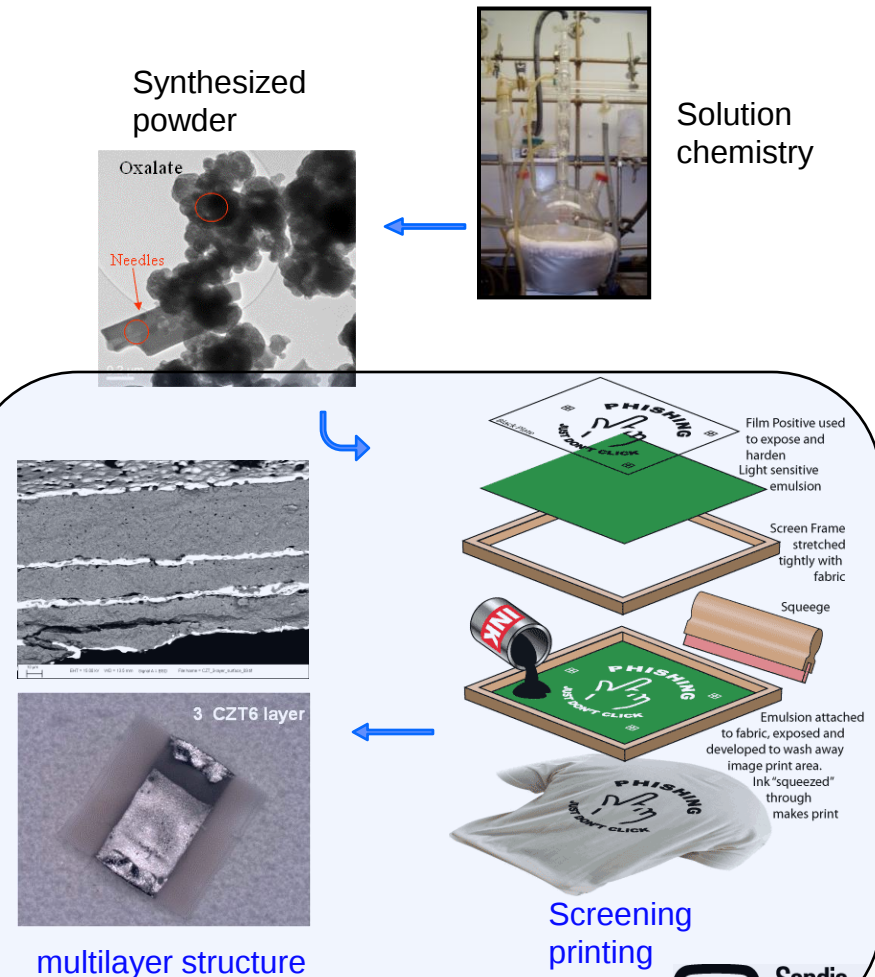
Previous work on CaZrO_3



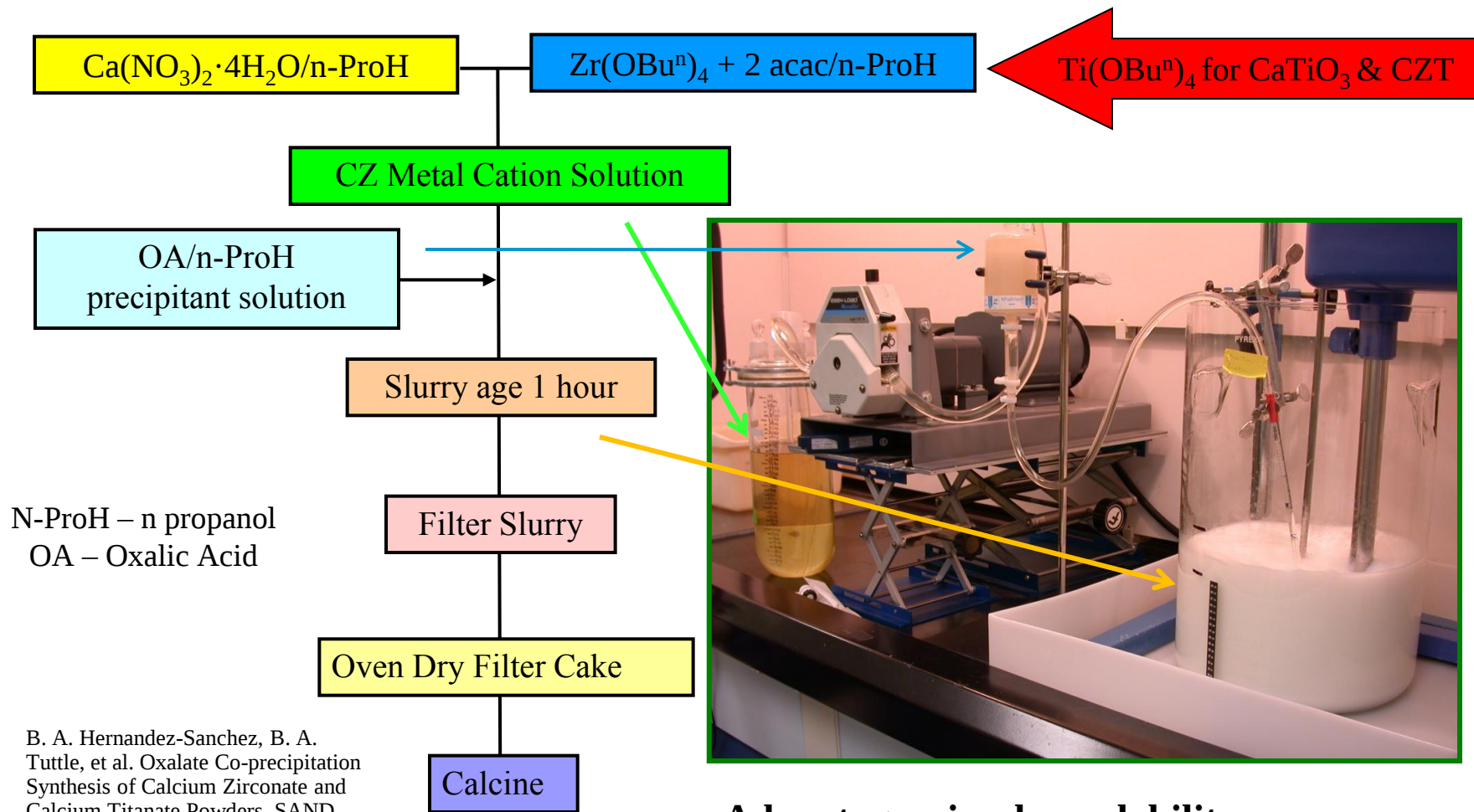
SNL CZ Thick Films (50 μm)
 measured under identical conditions
 $K \sim 30$, $E_{\text{bd}} = 1.5 \text{ MV/cm}$
 Energy Density = 2.9 J/cm^3

*ICC3, Osaka, Japan, Nov 2010

Current work on CZT90/10



Ca(Zr_{0.9}Ti_{0.1})O₃ Chem-Prep Powder Synthesis Process

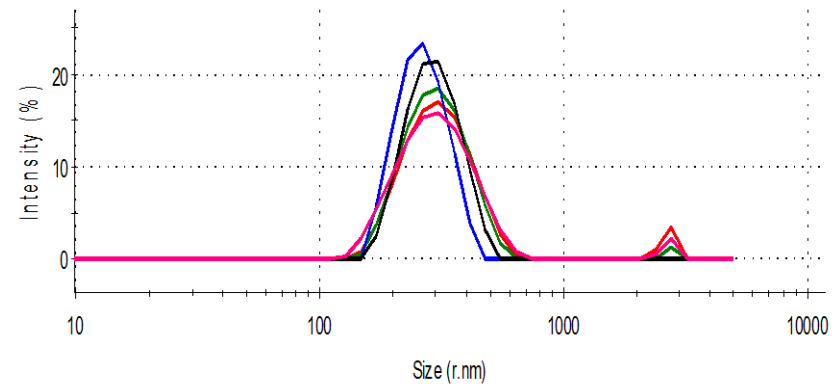
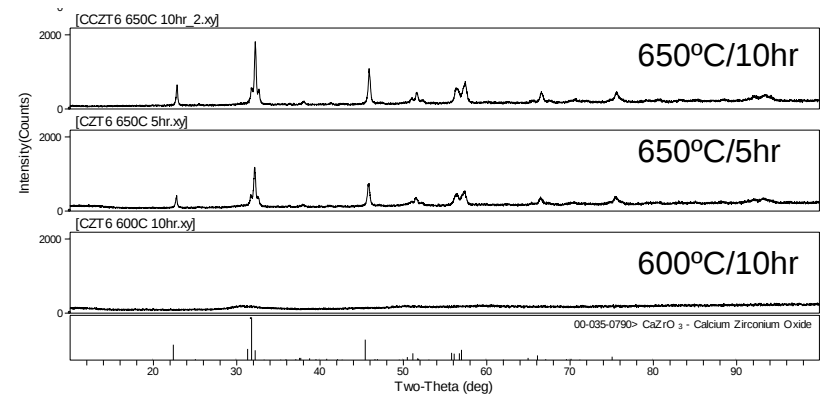


B. A. Hernandez-Sanchez, B. A. Tuttle, et al. Oxalate Co-precipitation Synthesis of Calcium Zirconate and Calcium Titanate Powders, SAND 2009-4743

Advantage: simple, scalability

Processing of CZT 90/10

- Calcination: 650°C/10hr
 - 2.5 hr attrition mill in IPA using PVP-K16 surfactant
 - $d_{50} \sim 300$ nm
- Pellet
 - 12.5 mm diameter x 1 mm thick
 - 5k Psi uniaxial followed by 30k psi isostatic pressing
- CZT90/10 paste
 - Paste: ESL441 organic vehicle and ESL401 thinner
- Free standing single and multi layer CZT capacitors with Pt achieved by special printing, substrate, setter and cofiring techniques



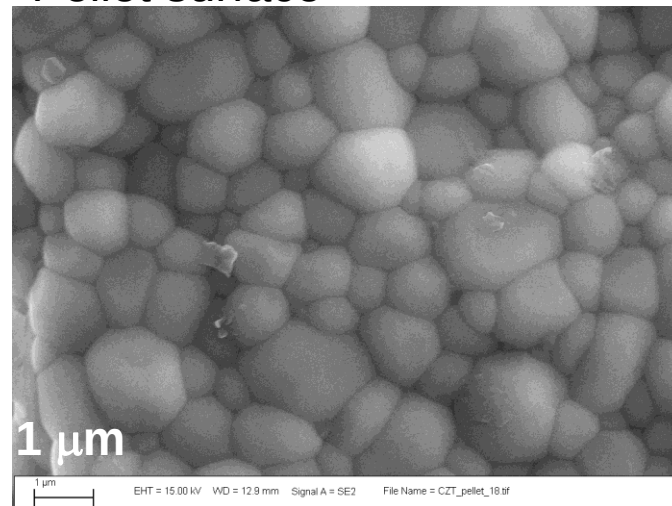
Sintering of CZT90/10

- 2-step sintering for high density and fine grain size*
 - Standard sintering: 1450°C/1hr + 1350°C/10hr
- Pellet
 - Reached density 4.04 g/cc
 - Average Grain size ~ 1.0 μm
- Single and multilayer CZT from paste
 - Average grain size ~ 1.5 μm

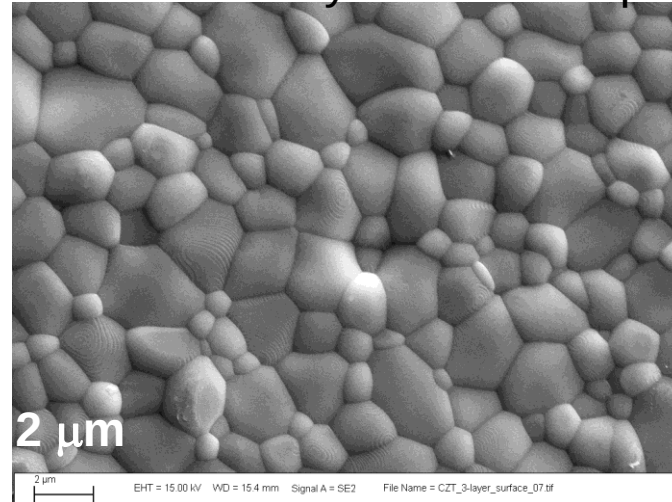
Step 1		Step 2		Pellet density (g/cc)
T (°C)	t (min)	T (°C)	t (min)	
1450	5	1300	600	4.00
1450	5	1350	600	3.92
1450	60	1300	600	3.91
1450	60	1350	600	4.04

*I.-Wei Chen & X.-H. Wang, "Sintering dense nanocrystalline ceramics without final-stage grain growth", *Nature* **404**, 168-171 (9 March 2000)

Pellet surface

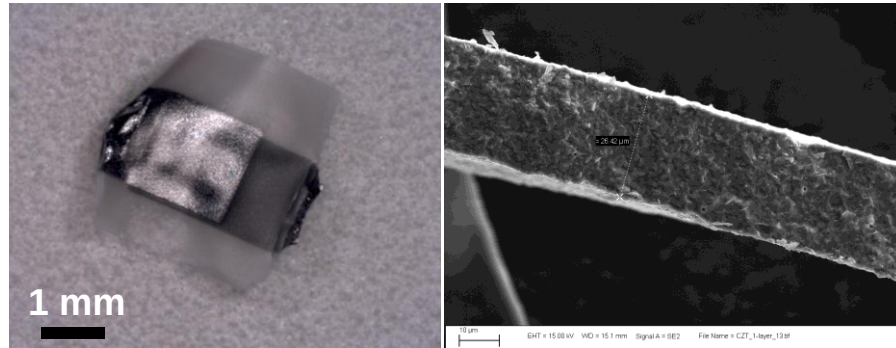


Surface multilayer CZT from paste



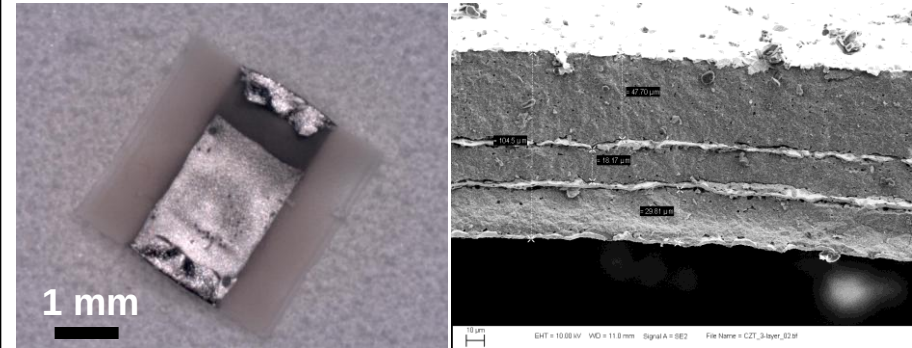
Free standing single and multilayer CZT/Pt

Single CZT6 layer with Pt



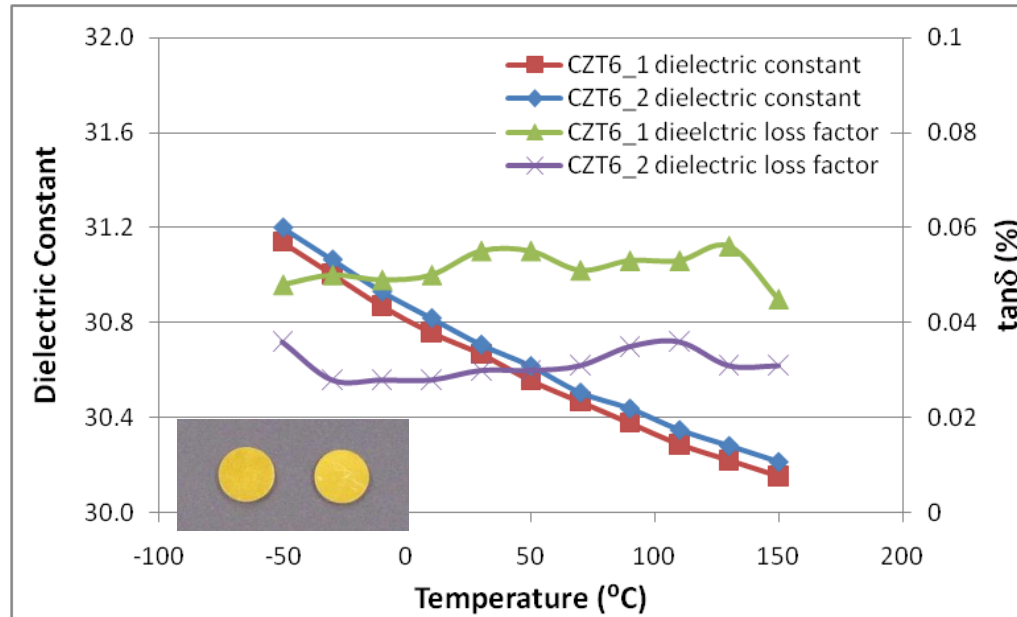
- Used special printing and sintering techniques for free standing Pt cofired CZT90/10
- The CZT layer is nearly transparent → highly dense microstructure
 - Multiple prints per layer
 - Sintered layer thickness ~ 26 μm
- Warping observed, but mostly crack free

3 CZT6 layers with Pt



- Multilayer build up using a sequential print-dry-print process
- The CZT layer is translucent → highly dense microstructure
 - Sintered layer thickness 18 ~ 48 μm
- Parts mostly flat without significant warping

Dielectric measurement -- pellet



Dielectric properties

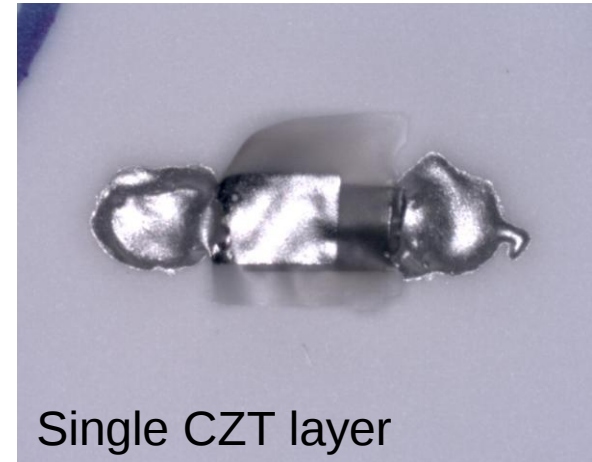
- Agilent 4194A, Sigma System temperature chamber
- $\epsilon = 31.2$ to 30.2 over -50 to 150 °C @ 1MHz
 - Very low dielectric loss

Temperature stability

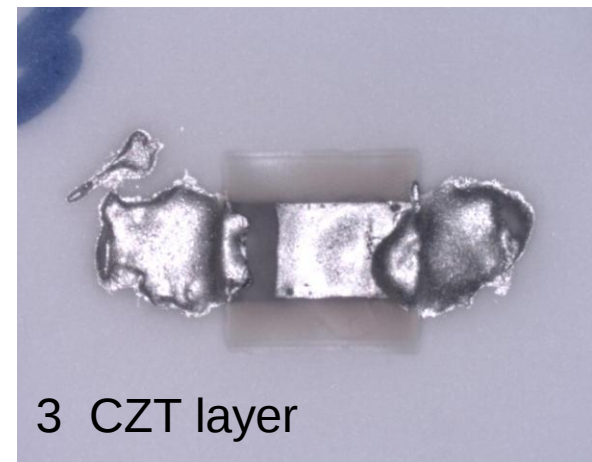
- $T_{cc} = -163$ °C/ppm
 - Compare to CZ: $\epsilon = 27.4$ to 27.7 ($T_{cc} = +55$ °C/ppm) over -50 to 150 °C
- Using linear appx, $T_{cc} \sim 0$ °C/ppm @ 2.5 mol% TiO_2
 - Higher than the 1.5mol% TiO_2 by Kell et al., J. Am Ceram Soc., Vol 57, No 7, P352, 1973

Dielectric measurement – single and multilayer CZT

- Samples are mounted on Al_2O_3 substrates with high conductivity Ag epoxy cured at $150^\circ\text{C}/30\text{min}$
- Agilent 4194A @ 1MHz
- The estimated K of single layer CZT is 34.2, higher than the 31.7 of bulk CZT, possibly due to higher density.
- The capacitance of 3 layer CZT is $\sim 3\times$ of that of single layer $\rightarrow$ scalable



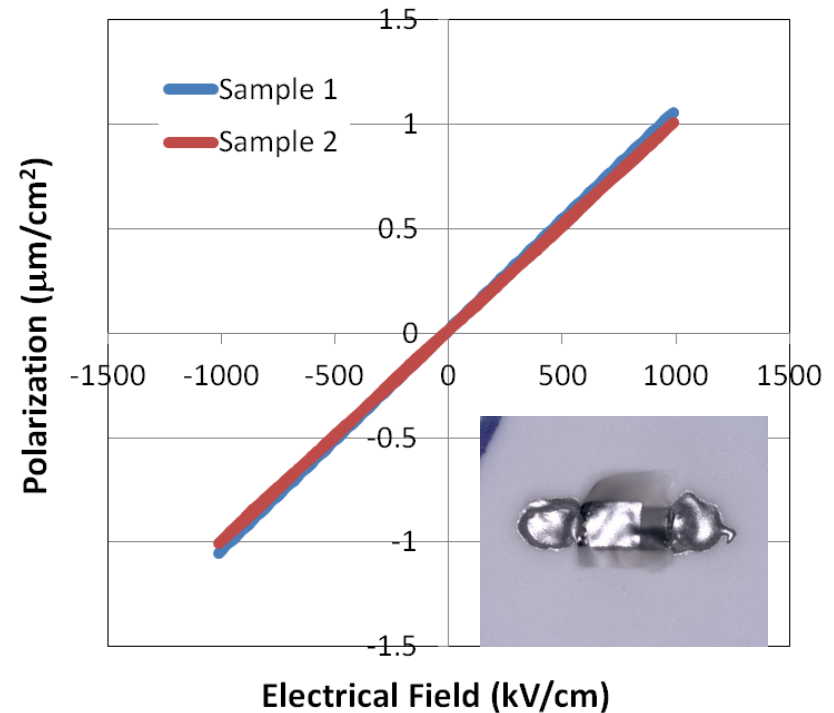
sample	1 layer			3 layers	
	C (pf)	$\tan\delta$	Estimated ϵ assuming $d = 26\ \mu\text{m}$	C (pf)	$\tan\delta$
1	46.83	0.034	34.4	135.41	0.037
2	48.85	0.044	35.9	125.10	0.025
3	45.53	0.037	33.4	133.91	0.027



* High ϵ consistent with SEM observation that there is less porosity in CZT film than the pellet samples

Dielectric breakdown -- single layer

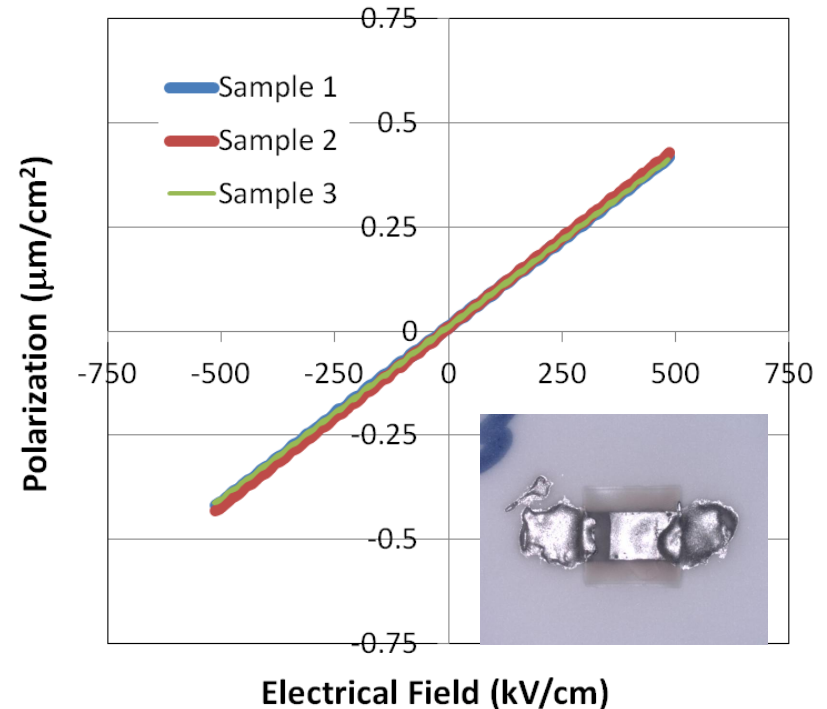
- Standard P-E (polarization vs electrical field) measurement ($V_{\text{max}} = 10\text{kV}$) was used to characterize the voltage limit and correspondent energy density
- The single layer CZT samples can constantly withstand 2kV
- Some discharging observed when voltage reaches 3kV
- $E = 1/2 \cdot \epsilon \cdot E^2$



sample	C (pf)	E density @ 1kV (J/cc)	E density @ 2kV (J/cc)	E density @ 3kV (J/cc)
1	47.35	0.30	1.18	2.66
2	47.35	0.30	1.18	2.66

Dielectric break down -- multilayer

- The 3-layer CZT samples can constantly withstand 1kV
- Some discharging observed when voltage reached 2kV
- The lower voltage limit may be attributed to one of the thinner layers in the stack
- Energy density is slighter lower for the multilayer CZT sample



sample	C (pf)	E density @ 1kV (J/cc)	E density @ 2kV (J/cc)
1	120.0	0.25	1.00
2	125.2	0.26	1.04
3	119.2	0.25	0.99



Summary

- Fine CZT90/10 powder has been synthesized via chemical route
- Free standing, high density single and multilayer CZT/Pt have been fabricated via sequential printing process and special sintering techniques
- The CZT90/10 achieved energy density $\sim 1.2 \text{ J/cm}^3$



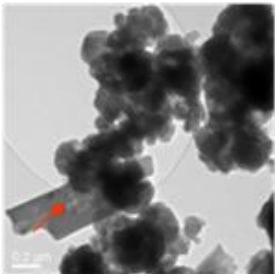
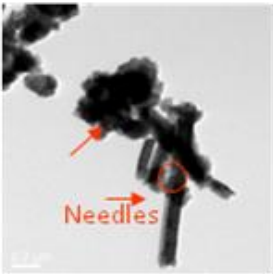
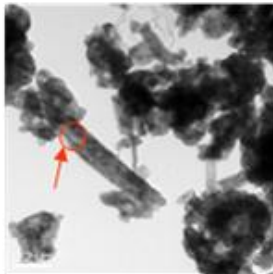
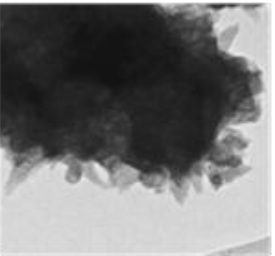
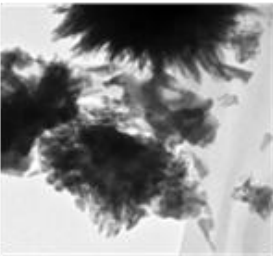
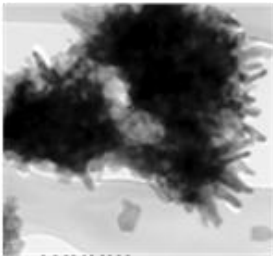
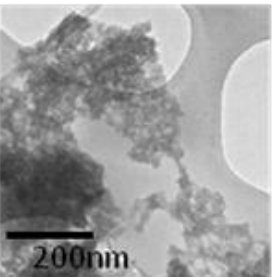
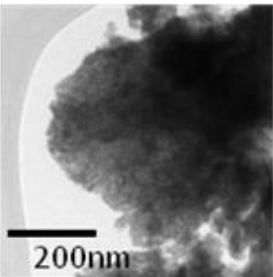
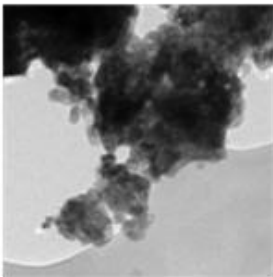
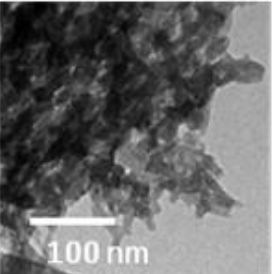
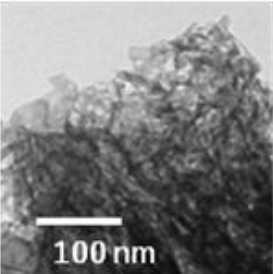
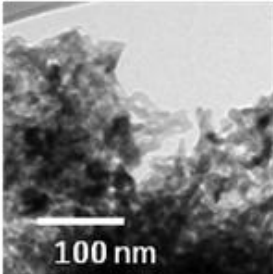
Future Work

- CZT composition with near zero T_{cc}
- Fine CZ and CZT powders by mixed-oxide method
- Low temperature sintering (<1200 °C) of CZ and CZT ceramics
- Microstructure with high density and small grain size for enhanced dielectric breakdown strength



Thank you!

TEM Images of Resulting Powder Morphology and Size After Heat Treatments

Sample	Oven Dried Oxalate	Pyrolyzed	Calcined	
CaZrO ₃				EDS and diffraction studies indicate needles are Ca _{0.15} Zr _{0.85} O _{1.85} while spherical powder is CaZrO ₃ .
CZT 90/10				Presence of Ca _{0.15} Zr _{0.85} O _{1.85} again shows up in needle or wire shape for CZT 90/10.
CZT 30/70				Lowered Zr stoichiometry of CZT 30/70 did not have needles.
CaTiO ₃				CaTiO ₃ powders had only agglomerated powders.